Searcn Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/528,877	CHANG ET AL.
Examiner	Art Unit
Amy L. Clark	1655

SEARCHED					
Class	Subclass	Date	Examiner		
100 CK	22C	1 SUNC	1210		
SON	In perf	N SUD CI			
	100				

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST/STN- See Search Notes	8/29/2007	ALC	
IDS Search Performed			
Japanese Patent Office Website			
PubMed			
Google			
PALM Inventor Search			